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Remarks:

This application was filed on 23 - 07 - 2004 as a divisional application to the application mentioned under INID code 62.

- (54)Metal barrier film production apparatus, metal barrier film production method, metal film production method, and metal film production apparatus
- A barrier metal film production method comprising: supplying a source gas containing a halogen to an interior of a chamber between a substrate and a metallic etched member; converting an atmosphere within the chamber into a plasma to generate a source gas plasma so that the etched member is etched with the source gas plasma to form a precursor from a metal component contained in the etched member and the source gas;

exciting a nitrogen-containing gas in a manner isolated from the chamber accommodating the substrate; forming a metal nitride upon reaction between excited nitrogen and the precursor; and making a temperature of the substrate lower than a temperature of means for formation of the metal nitride to form the metal nitride as a film on the substrate.